Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/620,266	CHEN ET AL.	_
Examiner	Art Unit	
Daniel D. Abebe	2626	

	SEARCHED				
Class	Subclass	Date	Examiner		
704	219, 500	6/13/2007	DA		
	,				

INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
	<u> </u>			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
NPL WEST	6/13/2007	DA
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